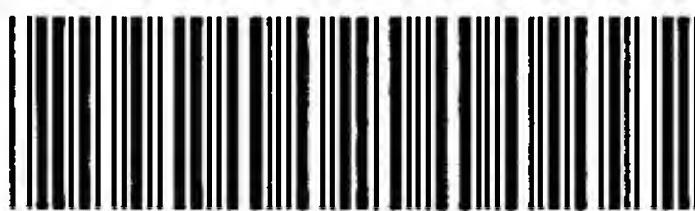


Search Notes



Application/Control No.

10/625.629

Examiner

Tu T. Nguyen

**Applicant(s)/Patent under
Reexamination**

VERMEIREN ET AL.

Art Unit

2877

SEARCHED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)